

NOTICE

(Special Make-up Test - Amendment to R14 Regulations)

The students of R14 regulations who cleared all the subjects except one, event that one subject they cleared the external examination (got 24 Marks) but failed in that subject due to shortage of Continuous Assessment – (CA/Internal Marks), '**Special or One time Make-up Test**' to improve the marks in the Continuous Assessment – (CA/Internal Marks) of **one subject** is offered due to Covid-19 pandemic conditions prevailed in the country for last 18 months.

The Students of Y14, Y15, Y16 & Y17 batch students may appear for the Make-up test for **one backlog subject** provided the student has already secured pass mark (24) in the external examination of that particular subject and no other backlogs in the four years.

1. The Make-up test will be conducted for 40 marks (8 x 1M, 2 x 16M) in Mid examination format and the marks obtained will be considered as final subject to a **maximum of 16 marks**.
2. The make-up test will be conducted on **19.11.2021** (Friday) at Exam section **HALL – 1 – 02.00 PM to 04.00 PM**.
3. The student has to apply to appear for the test by paying a fee of Rs. **1000/-** and submit the application by **15.11.2021** along with a letter of request indicating the genuineness of his/her candidature to be eligible for the make-up test with necessary proof.
4. The application should be recommended by the concerned HOD and approved by Principal.

The **Make-up Test** Examination fee should be deposited in the A/c. No. **31619409852** (**Autonomous Exam fee A/c**) of State Bank of India, Bapatla Engineering College Campus branch, Bapatla. **Students who pay the Exam fee in any other account will not be given any refund. They have to pay again the make-up test fee in the given A/c. only.**


PRINCIPAL

To:

All Notice Boards – including Library, Canteen and Hostel NBs
All Engg. HODs for n/a. & display in the departmental notice boards
Dr. J.S. Rao, Controller of Examinations
Dr. B. Ravi Sankar, Chief Superintendent, Mech. Dept.
The Examination Section